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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation Yes	Translation No

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	XP007907540; "Real multi-parent tri-hybrid evolutionary optimization method and its application in wind velocity estimation from wind profile data" Noel E. Mendoza[a]*, Yen-Wei Chen[a,c], Zensho Nakao[a], Tatsuhiro Adachi[b], Yoshihisa Masuda[b]; Applied Soft Computing, vol. 1, no. 3, December 30, 2001(12/30/2001), pages 225-235
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EXAMINER	DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.